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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,801	ABE ET AL.	
Examiner	Art Unit	
XIAO M. WU	2674	

SEARCHED			
Class	Subclass	Date	Examiner
345	74.1, 75.1 75.2, 76- 78	5/23/2005	X.W.
345	87-89	5/23/2005	X.W.
345	690-693	5/23/2005	X.W.
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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